

<b>Notice of References Cited</b>	Application/Control No. 10/629,402		Applicant(s)/Patent Under Reexamination TANNER, BRIAN K.	
	Examiner Patrick Miller		Art Unit 2837	Page 1 of 1

#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,266,203	07-2001	Street et al.	360/69
	B	US-5,268,804	12-1993	Wallis, Christopher N.	360/78.04
	C	US-5,204,593	04-1993	Ueki, Yasuhiro	318/254
	D	US-2004/0124799	07-2004	Tanner, Brian K.	318/471
	E	US-6,078,158	06-2000	Heeren et al.	318/430
	F	US-6,392,833	05-2002	Wood et al.	360/73.03
	G	US-6,342,985	01-2002	Clare et al.	360/75
	H	US-6,088,662	07-2000	Flinsbaugh et al.	702/132
	I	US-6,744,586	06-2004	Ukani et al.	360/69
	J	US-			
	K	US-			
	L	US-			
	M	US-			

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 2000222815 A	08-2000	Japan	IIDA, MICHIIHIKO	G11B 19/28
	O	JP 05120859 A	05-1993	Japan	TAKEMORI, HIROSHI	G11B 33/14
	P					
	Q					
	R					
	S					
	T					

#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
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